

Chipsmall Limited consists of a professional team with an average of over 10 year of expertise in the distribution of electronic components. Based in Hongkong, we have already established firm and mutual-benefit business relationships with customers from, Europe, America and south Asia, supplying obsolete and hard-to-find components to meet their specific needs.

With the principle of "Quality Parts, Customers Priority, Honest Operation, and Considerate Service", our business mainly focus on the distribution of electronic components. Line cards we deal with include Microchip, ALPS, ROHM, Xilinx, Pulse, ON, Everlight and Freescale. Main products comprise IC, Modules, Potentiometer, IC Socket, Relay, Connector. Our parts cover such applications as commercial, industrial, and automotives areas.

We are looking forward to setting up business relationship with you and hope to provide you with the best service and solution. Let us make a better world for our industry!



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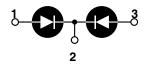
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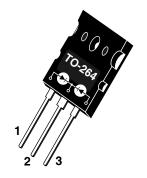








- 1 Anode 1
- 2 Common Cathode Back of Case - Cathode
- 3-Anode 2





APT100S20LCT(G) 200V 120A

G Denotes RoHS Compliant, Pb Free Terminal Finish

HIGH VOLTAGE SCHOTTKY DIODE

PRODUCT APPLICATIONS PRODUCT FEATURES PRODUCT BENEFITS • Ultrafast Recovery Times Low Losses Parallel Diode -Switchmode Power Supply Soft Recovery Characteristics Low Noise Switching -Inverters • Free Wheeling Diode • Popular TO-264 Package Cooler Operation -Motor Controllers • Rugged --Converters • Higher Reliability Systems **Avalanche Energy Rated** Snubber Diode • Uninterruptible Power Supply (UPS) • Increased System Power • Low Forward Voltage • 48 Volt Output Rectifiers Density • High Blocking Voltage • High Speed Rectifiers Low Leakage Current

MAXIMUM RATINGS

All Ratings Are Per Leg: $T_C = 25^{\circ}C$ unless otherwise specified.

Symbol	Characteristic / Test Conditions	APT100S20LCT(G)	UNIT
V_{R}	Maximum D.C. Reverse Voltage		
V _{RRM}	Maximum Peak Repetitive Reverse Voltage	200	Volts
V _{RWM}	Maximum Working Peak Reverse Voltage		
I _F (AV)	Maximum Average Forward Current (1) (T _C = 125°C, Duty Cycle = 0.5)	120	
I _F (RMS)	RMS Forward Current (Square wave, 50% duty) (1)	318	Amps
I _{FSM}	Non-Repetitive Forward Surge Current (T _J = 45°C, 8.3ms)	1000	
T_J, T_STG	Operating and StorageTemperature Range	-55 to 150	°C
T _L	Lead Temperature for 10 Sec.	300	
E _{VAL}	Avalanche Energy (2A, 50mH)	100	mJ

STATIC ELECTRICAL CHARACTERISTICS

Symbol			MIN	TYP	MAX	UNIT
V _F	Forward Voltage	I _F = 100A		.89	.95	Volts
		I _F = 200A		1.06		
		I _F = 100A, T _J = 125°C		.76		
I _{RM}	Maximum Reverse Leakage Current	V _R = V _R Rated			2	mA
		$V_R = V_R$ Rated, $T_J = 125$ °C			40	
C _T	Junction Capacitance, V _R = 200V			470		pF

DYNAMIC CHARACTERISTICS

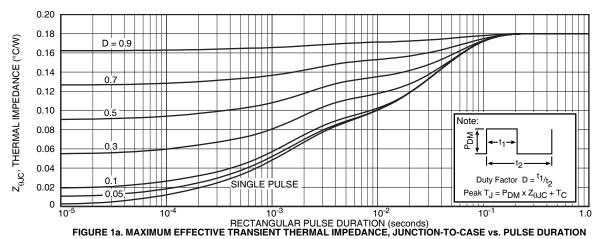
Symbol	Characteristic	Test Conditions	MIN	TYP	MAX	UNIT
t _{rr}	Reverse Recovery Time	$I_F = 100A, di_F/dt = -200A/\mu s$ $V_R = 133V, T_C = 25^{\circ}C$	-	70		ns
Q _{rr}	Reverse Recovery Charge		-	230		nC
I _{RRM}	Maximum Reverse Recovery Current		-	6	-	Amps
t _{rr}	Reverse Recovery Time	$I_F = 100A$, $di_F/dt = -200A/\mu s$ $V_R = 133V$, $T_C = 125^{\circ}C$	-	110		ns
Q _{rr}	Reverse Recovery Charge		-	690		nC
I _{RRM}	Maximum Reverse Recovery Current		-	11	-	Amps
t _{rr}	Reverse Recovery Time	$I_F = 100A, di_F/dt = -700A/\mu s$ $V_R = 133V, T_C = 125^{\circ}C$	-	95		ns
Q _{rr}	Reverse Recovery Charge		-	1750		nC
I _{RRM}	Maximum Reverse Recovery Current		-	32		Amps

THERMAL AND MECHANICAL CHARACTERISTICS

Symbol	Characteristic / Test Conditions	MIN	TYP	MAX	UNIT
$R_{\theta JC}$	Junction-to-Case Thermal Resistance			.18	°C/W
W _T	Package Weight		0.22		oz
			5.9		g
Torque	Maximum Mounting Torque			10	lb•in
				1.1	N•m

 $Microsemi\,reserves\,the\,right\,to\,change, without\,notice, the\,specifications\,and\,information\,contained\,herein.$

① Countinous current limited by package lead temperature.



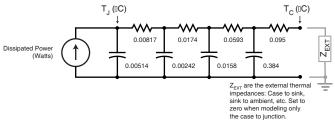


FIGURE 1b, TRANSIENT THERMAL IMPEDANCE MODEL

TYPICAL PERFORMANCE CURVES

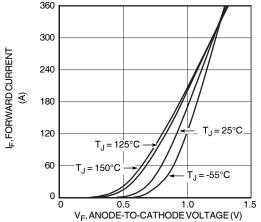


Figure 2. Forward Current vs. Forward Voltage

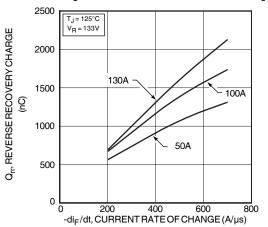


Figure 4. Reverse Recovery Charge vs. Current Rate of Change

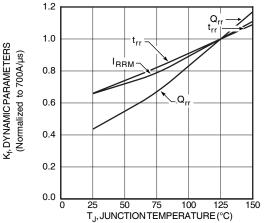


Figure 6. Dynamic Parameters vs. Junction Temperature

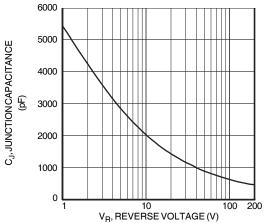


Figure 8. Junction Capacitance vs. Reverse Voltage

APT100S20LCT(G)

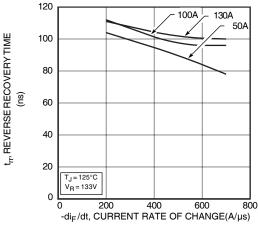


Figure 3. Reverse Recovery Time vs. Current Rate of Change

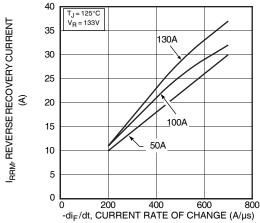


Figure 5. Reverse Recovery Current vs. Current Rate of Change

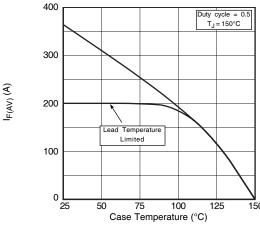


Figure 7. Maximum Average Forward Current vs. CaseTemperature

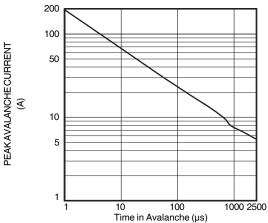


Figure 9. Single Pulse UIS SOA

Figure 9. Diode Test Circuit

- I_F Forward Conduction Current $\mathrm{di}_{\mathrm{F}}/\mathrm{dt}$ - Rate of Diode Current Change Through Zero Crossing. Zero $\mathbf{I}_{\mathsf{RRM}}$ - Maximum Reverse Recovery Current. 6 0.25 I_{RRM}
- $t_{\mbox{rr}}$ Reverse Recovery Time, measured from zero crossing where diode current goes from positive to negative, to the point at which the straight line through $\rm I_{RRM}$ and $\rm 0.25 {}^{\bullet}I_{RRM}$ passes through zero.
- $\mathbf{5}$ \mathbf{Q}_{rr} Area Under the Curve Defined by \mathbf{I}_{RRM} and \mathbf{t}_{rr} .

Figure 10, Diode Reverse Recovery Waveform and Definitions

